## Search Notes



10767227

Reexamination

Applicant(s)/Patent Under

WELCH ET AL.

Examiner

Hoang, Hieu T

Art Unit

2152

## **SEARCHED**

Class	Subclass	Date	Examiner
709	230-237	8/15/2007	HH

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST	8/15/2007	HH		
Updated EAST	2/11/2008	HH		
Updated EAST	6/10/2008	HH		

	INTERFERENCE SEA	INTERFERENCE SEARCH		
Class	Subclass	Date	Examiner	

U.S. Patent and Trademark Office Part of Paper No.: 20080610